
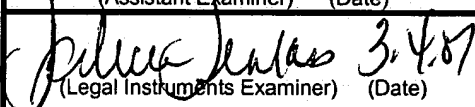


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/685,473	KLEIN, MARTIN G.	
	Examiner	Art Unit	
	Dah-Wei D. Yuan	1745	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
429		122			429	128	142			
INTERNATIONAL CLASSIFICATION										
H	0	1	M	6/00						
H	0	1	M	4/00						
H	0	1	M	2/16						
				/						
				/						

(Assistant Examiner) (Date)		<b>DAH-WEI YUAN</b> <b>PRIMARY EXAMINER</b> Dah-Wei Yuan 2/22/07 (Primary Examiner) (Date)	Total Claims Allowed: 31	
 (Legal Instruments Examiner) (Date)			O.G. Print Claim(s)	O.G. Print Fig.
			1	2

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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